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XPX35P10FD

# -100V P-Channel Enhancement Mode MOSFET

#### Description

The XPX35P10FD uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

#### Application

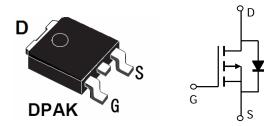
Brushless motor

Load switch

Uninterruptible power supply



 $V_{DS} = -100V, I_D = -35A$ RDS(ON)=83mΩ (typ) @ VGS=-10V RDS(ON)=95mΩ (typ) @ VGS=-4.5V



#### Package Marking and Ordering Information

Product ID	Pack	Marking	<b>Qty(PCS)</b> 2500	
XPX35P10FD	TO-252-3L	XPX35P10FD XXXX YYYY		
osolute Maximum	n Ratings (Tc=25℃unless otherwise no	ted)		
Symbol	Symbol Parameter		Units	
Vds	Drain-Source Voltage	-100	V	
Vgs	Gate-Source Voltage	±20	V	
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, $V_{GS}$ @ -10V <sup>1</sup>	-35	А	
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, $V_{GS}$ @ -10V <sup>1</sup>	-18	А	
Ідм	Pulsed Drain Current <sup>2</sup>	-96	А	
EAS	Single Pulse Avalanche Energy <sup>3</sup>	87	mJ	
las	Avalanche Current	-35	А	
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	on <sup>4</sup> 76		
Тѕтс	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
R <sub>0</sub> JA	Thermal Resistance Junction-Ambient <sup>1</sup>	55	°C/W	
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	1.0	°C/W	



### P-Channel Electrical Characteristics (TJ =25 °C, unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units	
V(BR)DSS	Drain-Source Breakdown Voltage V <sub>GS</sub> =0V, I <sub>D</sub> =-250µA		-100	-	-	V	
IDSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-100V, V <sub>GS</sub> =0V,	-	-	-1.0	μA	
IGSS	Gate to Body Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V	-	-	±100	nA	
VGS(th)	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250µA	-1.0	-1.6	-2.5	V	
RDS(on) S	Static Drain-Source on-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A	-	83	98	mΩ	
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-10A	-	95	105	11122	
Ciss	Input Capacitance		-	1365	-	pF	
Coss	Output Capacitance	V <sub>DS</sub> =-50V, V <sub>GS</sub> =0V, f=1.0MHz	-	136	-	pF	
Crss	Reverse Transfer Capacitance	1 1.00012	-	20	-	pF	
Qg	Total Gate Charge		-	40	-	nC	
Qgs	Gate-Source Charge	V <sub>DS</sub> =-50V, I <sub>D</sub> =-5A, V <sub>GS</sub> =-10V	-	7.8	-	nC	
Qgd	Gate-Drain("Miller") Charge	VG510V	-	8.6	-	nC	
td(on)	Turn-on Delay Time		-	13	-	ns	
tr	Turn-on Rise Time V <sub>DD</sub> =-50V, I <sub>D</sub> =-5A,		-	39	-	ns	
td(off)	Turn-off Delay Time			101	-	ns	
t <sub>f</sub>	Turn-off Fall Time		-	106	-	ns	
IS	Maximum Continuous Drain to Source Diode Forward Current			-	-35	А	
ISM	Maximum Pulsed Drain to Source Diode Forward Current			-	-140	А	
VSD	Drain to Source Diode Forward Voltage V <sub>GS</sub> =0V, I <sub>S</sub> =-30A		-	-	-1.2	V	
trr	Body Diode Reverse Recovery Time T <sub>J</sub> =25°C,		-	104	-	ns	
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge I⊧=-5A,dl/dt=100A/µs		-	280	-	nC	

Note :

1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

2. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%

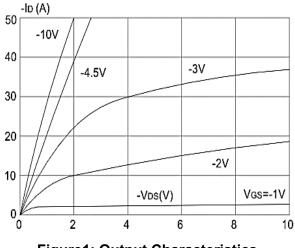
3、The EAS data shows Max. rating . The test condition is V DD =-25V,V GS =-10V,L=0.1mH,IAS =-24A

 $4\,{}_{\sim}\,$  The power dissipation is limited by 150  ${}^{\circ}\!{}^{\circ}_{\sim}$  junction temperature

5. The data is theoretically the same as I D and I DM, in real applications, should be limited by total power dissipation.







### Figure1: Output Characteristics

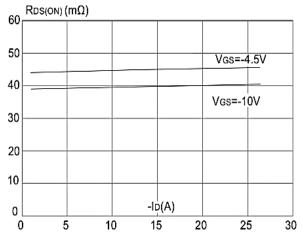
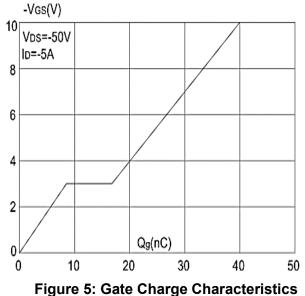


Figure 3:On-resistance vs. Drain Current



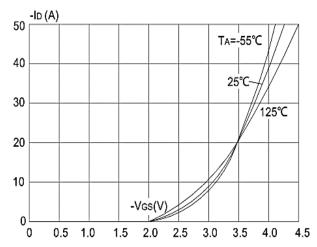


Figure 2: Typical Transfer Characteristics

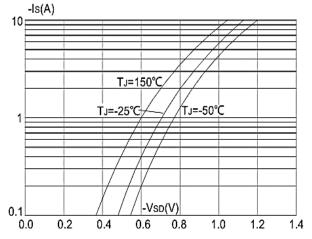
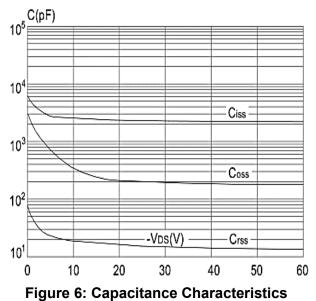


Figure 4: Body Diode Characteristics





200

175

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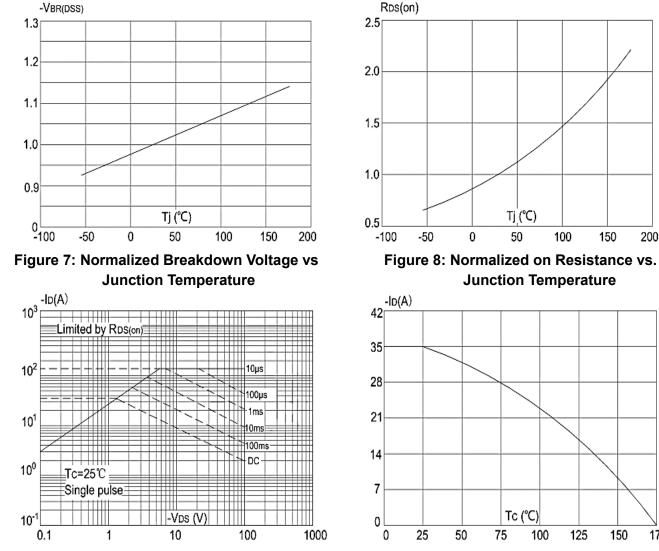
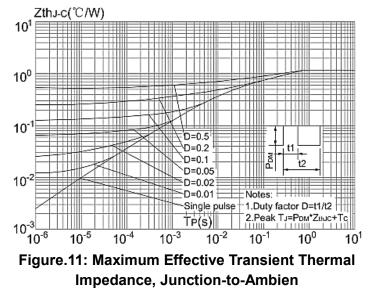


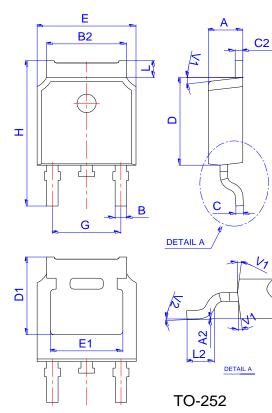
Figure 9: Maximum Safe Operating Area





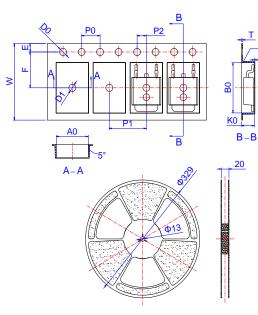


# Package Mechanical Data: TO-252-3L



	Dimensions						
Ref.	Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
A	2.10		2.50	0.083		0.098	
A2	0		0.10	0		0.004	
В	0.66		0.86	0.026		0.034	
B2	5.18		5.48	0.202		0.216	
С	0.40		0.60	0.016		0.024	
C2	0.44		0.58	0.017		0.023	
D	5.90		6.30	0.232		0.248	
D1	5.30REF			0.209REF			
E	6.40		6.80	0.252		0.268	
E1	4.63			0.182			
G	4.47		4.67	0.176		0.184	
Н	9.50		10.70	0.374		0.421	
L	1.09		1.21	0.043		0.048	
L2	1.35		1.65	0.053		0.065	
V1		7°			7°		
V2	0°		6°	0°		6°	

# **Reel Spectification-TO-252**



			Dimensions					
-5*MAX Ref.		Millimeters			Inches			
		Min.	Тур.	Max.	Min.	Тур.	Max.	
	W	15.90	16.00	16.10	0.626	0.630	0.634	
	E	1.65	1.75	1.85	0.065	0.069	0.073	
	F	7.40	7.50	7.60	0.291	0.295	0.299	
	D0	1.40	1.50	1.60	0.055	0.059	0.063	
	D1	1.40	1.50	1.60	0.055	0.059	0.063	
	P0	3.90	4.00	4.10	0.154	0.157	0.161	
	P1	7.90	8.00	8.10	0.311	0.315	0.319	
	P2	1.90	2.00	2.10	0.075	0.079	0.083	
	A0	6.85	6.90	7.00	0.270	0.271	0.276	
	B0	10.45	10.50	10.60	0.411	0.413	0.417	
	K0	2.68	2.78	2.88	0.105	0.109	0.113	
	Т	0.24		0.27	0.009		0.011	
	t1	0.10			0.004			
	10P0	39.80	40.00	40.20	1.567	1.575	1.583	

t1



#### Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time		
Pb device	<b>245℃±5</b> ℃	5sec <del>±</del> 1sec		
Pb-Free device	<b>260</b> ℃+0/-5℃	5sec <del>±</del> 1sec		



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